


<b>Search Notes</b> 	<b>Application/Control No.</b> 10574017	<b>Applicant(s)/Patent Under Reexamination</b> NAKAGAWA ET AL.
	<b>Examiner</b> Patton, Paul E	<b>Art Unit</b> 2822

SEARCHED			
Class	Subclass	Date	Examiner
257	787-790,795,667,687,704	10/4/2007	PEP
438	106,107,110-112,120-127,26	10/4/2007	PEP

SEARCH NOTES			
Search Notes		Date	Examiner
Search History Attached		10/4/2007	PEP
Consult with Kevin Picardat		10/4/2007	PRP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	787-790,795,667,687,704	10/4/2007	PEP
438	106,107,110-112,120-127,26	10/4/2007	PEP